

Notice of References Cited

Application/Control No.

10/553,112

Applicant(s)/Patent Under
Reexamination
KIEREN ET AL.

Examiner

Chuong P. Nguyen

Art Unit

3663

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0069006 A1	06-2002	Faye et al.	701/70
*	B	US-6,438,463 B1	08-2002	Tobaru et al.	701/1
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NON-PATENT DOCUMENTS

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